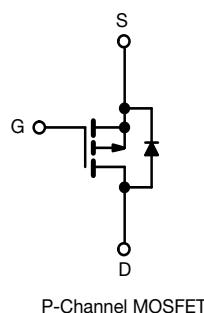
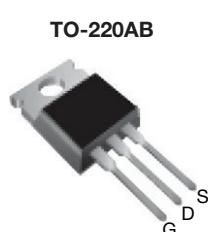


Power MOSFET

PRODUCT SUMMARY	
V_{DS} (V)	-200
$R_{DS(on)}$ (Ω)	$V_{GS} = -10$ V 0.50
Q_g max. (nC)	44
Q_{gs} (nC)	7.1
Q_{gd} (nC)	27
Configuration	Single



FEATURES

- Dynamic dv/dt rating
- Repetitive avalanche rated
- P-channel
- Fast switching
- Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



RoHS*
Available

Note

* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non-RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details.

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRF9640PbF SiHF9640-E3
SnPb	IRF9640 SiHF9640

ABSOLUTE MAXIMUM RATINGS ($T_C = 25$ °C, unless otherwise noted)				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V_{DS}	-200	V
Gate-Source Voltage		V_{GS}	± 20	V
Continuous Drain Current	V_{GS} at -10 V	I_D	-11	A
			-6.8	
Pulsed Drain Current ^a		I_{DM}	-44	
Linear Derating Factor			1.0	W/°C
Single Pulse Avalanche Energy ^b		E_{AS}	700	mJ
Repetitive Avalanche Current ^a		I_{AR}	-11	A
Repetitive Avalanche Energy ^a		E_{AR}	13	mJ
Maximum Power Dissipation	$T_C = 25$ °C	P_D	125	W
Peak Diode Recovery dv/dt ^c		dV/dt	-5.0	V/ns
Operating Junction and Storage Temperature Range		T_J, T_{stg}	-55 to +150	°C
Soldering Recommendations (Peak temperature) ^d	for 10 s		300	
Mounting Torque	6-32 or M3 screw		10	lbf · in
			1.1	N · m

Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- $V_{DD} = -50$ V, starting $T_J = 25$ °C, $L = 8.7$ mH, $R_g = 25$ Ω , $I_{AS} = -11$ A (see fig. 12).
- $I_{SD} \leq -11$ A, $dv/dt \leq 150$ A/ μ s, $V_{DD} \leq V_{DS}$, $T_J \leq 150$ °C.
- 1.6 mm from case.

THERMAL RESISTANCE RATINGS

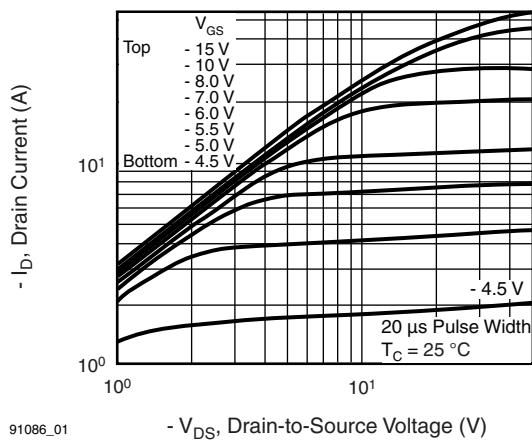
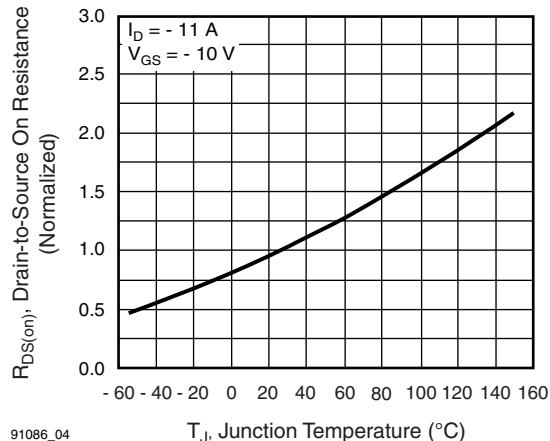
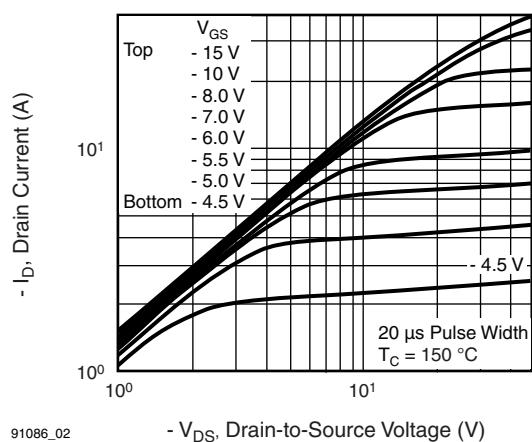
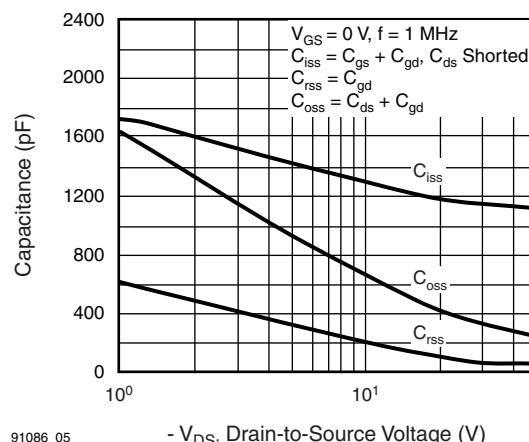
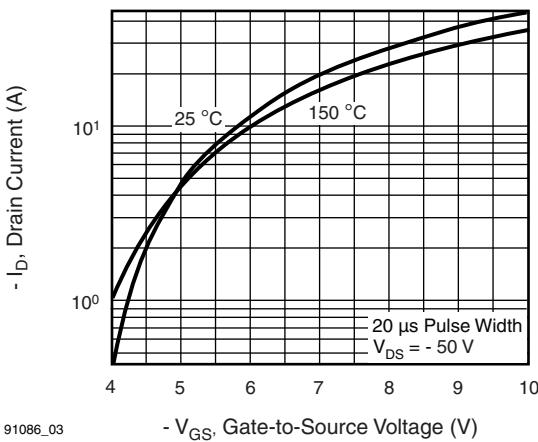
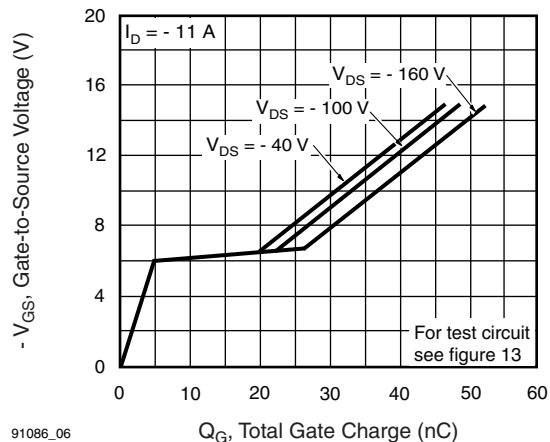
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R_{thJA}	-	62	$^{\circ}\text{C}/\text{W}$
Case-to-Sink, Flat, Greased Surface	R_{thCS}	0.50	-	
Maximum Junction-to-Case (Drain)	R_{thJC}	-	1.0	

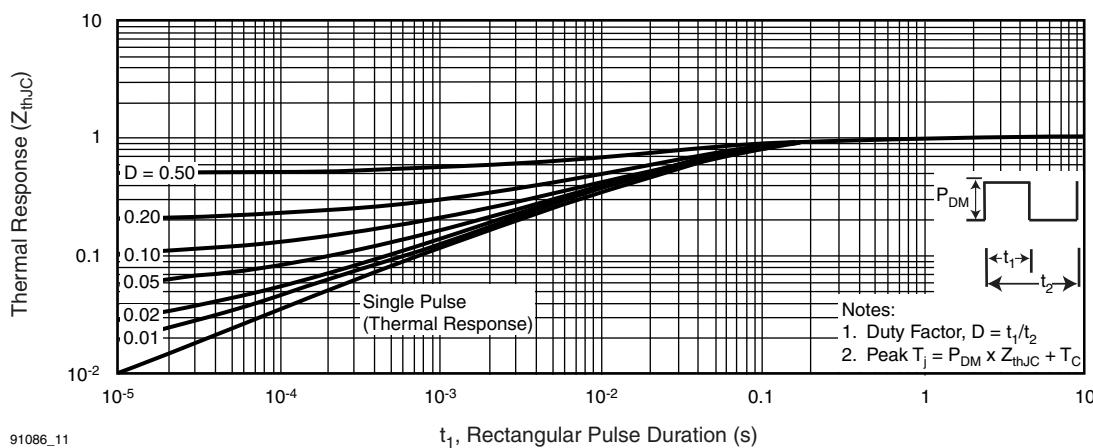
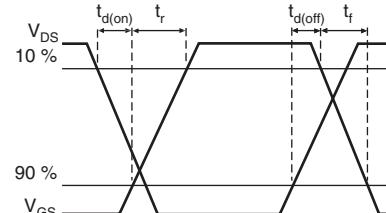
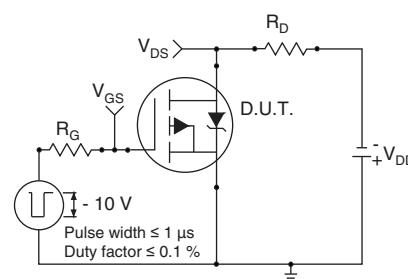
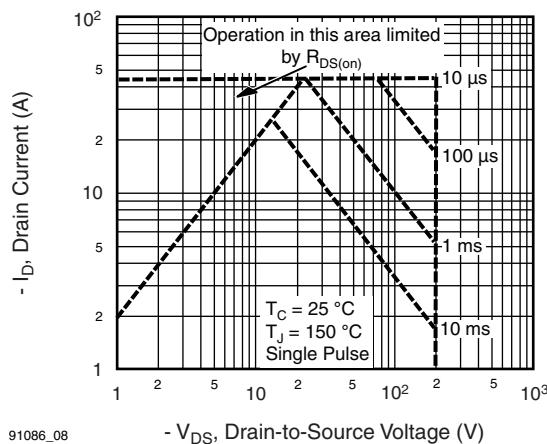
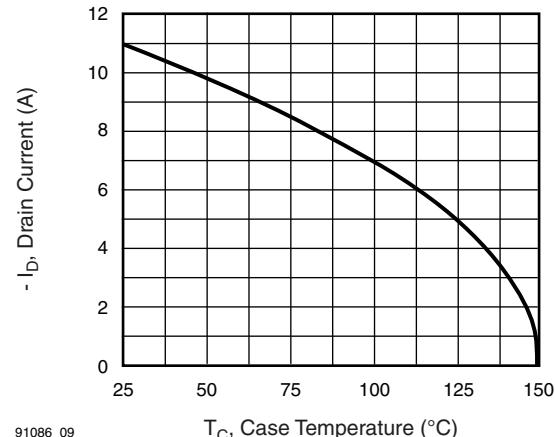
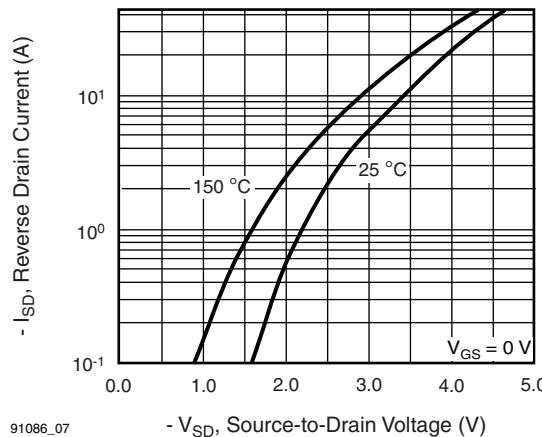
SPECIFICATIONS ($T_J = 25 \text{ }^{\circ}\text{C}$, unless otherwise noted)

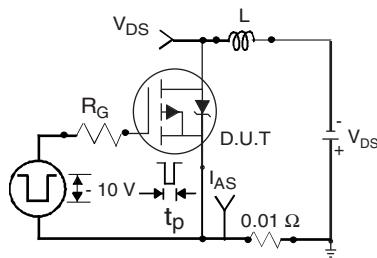
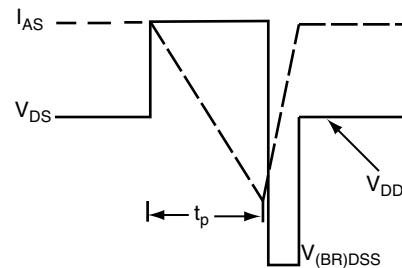
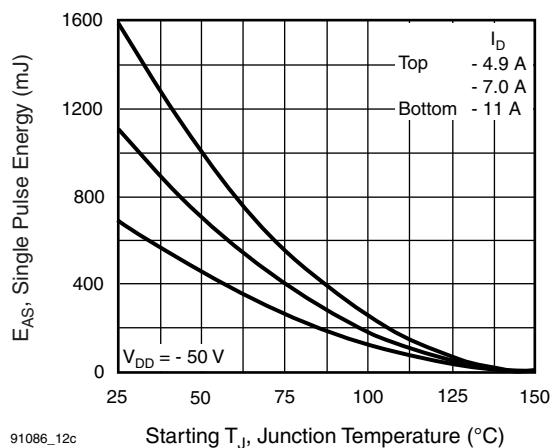
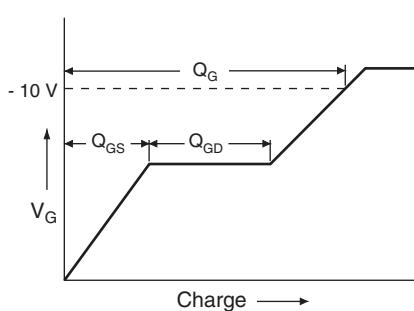
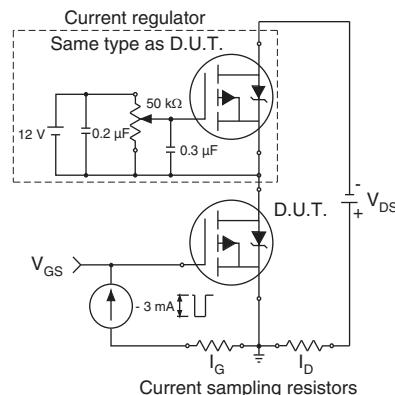
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}$, $I_D = -250 \mu\text{A}$		-200	-	-	V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to $25 \text{ }^{\circ}\text{C}$, $I_D = -1 \text{ mA}$		-	-0.2	-	$\text{V}/^{\circ}\text{C}$
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = -250 \mu\text{A}$		-2.0	-	-4.0	V
Gate-Source Leakage	I_{GSS}	$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -200 \text{ V}$, $V_{GS} = 0 \text{ V}$		-	-	-100	μA
		$V_{DS} = -160 \text{ V}$, $V_{GS} = 0 \text{ V}$, $T_J = 125 \text{ }^{\circ}\text{C}$		-	-	-500	
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = -10 \text{ V}$	$I_D = -6.6 \text{ A}^b$	-	-	0.50	Ω
Forward Transconductance	g_{fs}	$V_{DS} = -50 \text{ V}$, $I_D = -6.6 \text{ A}^b$		4.1	-	-	S
Dynamic							
Input Capacitance	C_{iss}	$V_{GS} = 0 \text{ V}$, $V_{DS} = -25 \text{ V}$, $f = 1.0 \text{ MHz}$, see fig. 5		-	1200	-	pF
Output Capacitance	C_{oss}			-	370	-	
Reverse Transfer Capacitance	C_{rss}			-	81	-	
Total Gate Charge	Q_g	$V_{GS} = -10 \text{ V}$	$I_D = -11 \text{ A}$, $V_{DS} = -160 \text{ V}$, see fig. 6 and 13 ^b	-	-	44	nC
Gate-Source Charge	Q_{gs}			-	-	7.1	
Gate-Drain Charge	Q_{gd}			-	-	27	
Turn-On Delay Time	$t_{d(on)}$			-	14	-	
Rise Time	t_r	$V_{DD} = -100 \text{ V}$, $I_D = -11 \text{ A}$ $R_g = 9.1 \Omega$, $R_D = 8.6 \Omega$, see fig. 10 ^b		-	43	-	ns
Turn-Off Delay Time	$t_{d(off)}$		-	39	-		
Fall Time	t_f		-	38	-		
Internal Drain Inductance	L_D		-	4.5	-		
Internal Source Inductance	L_S	Between lead, 6 mm (0.25") from package and center of die contact		-	7.5	-	nH
Gate Input Resistance	R_g	$f = 1 \text{ MHz}$, open drain		0.3	-	1.7	Ω
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I_S	MOSFET symbol showing the integral reverse p-n junction diode		-	-	-11	A
Pulsed Diode Forward Current ^a	I_{SM}			-	-	-44	
Body Diode Voltage	V_{SD}	$T_J = 25 \text{ }^{\circ}\text{C}$, $I_S = -11 \text{ A}$, $V_{GS} = 0 \text{ V}^b$		-	-	-5	V
Body Diode Reverse Recovery Time	t_{rr}	$T_J = 25 \text{ }^{\circ}\text{C}$, $I_F = -11 \text{ A}$, $dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	250	300	ns
Body Diode Reverse Recovery Charge	Q_{rr}			-	2.9	3.6	μC
Forward Turn-On Time	t_{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)					

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300 \mu\text{s}$; duty cycle $\leq 2 \%$.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Fig. 1 - Typical Output Characteristics, $T_c = 25^\circ\text{C}$

Fig. 4 - Normalized On-Resistance vs. Temperature

Fig. 2 - Typical Output Characteristics, $T_c = 150^\circ\text{C}$

Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

Fig. 3 - Typical Transfer Characteristics

Fig. 6 - Typical Gate Charge vs. Drain-to-Source Voltage




Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

Fig. 12c - Maximum Avalanche Energy vs. Drain Current

Fig. 13a - Basic Gate Charge Waveform

Fig. 13b - Gate Charge Test Circuit

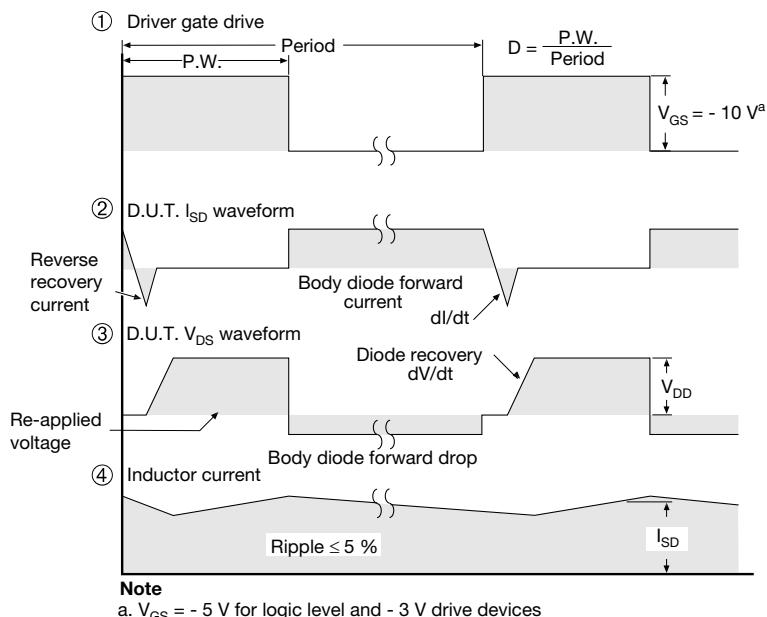
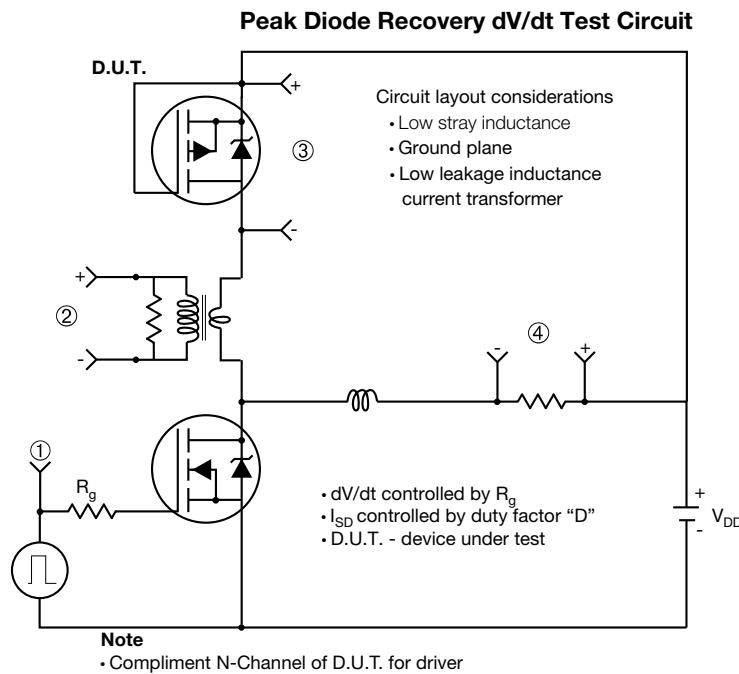
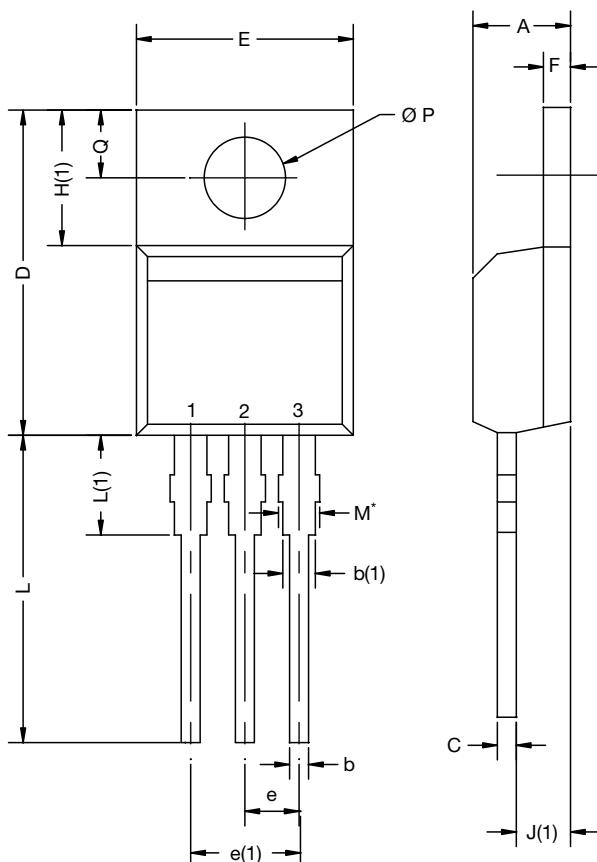


Fig. 14 - For P-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <http://www.vishay.com/ppg?91086>.

TO-220-1



DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	4.24	4.65	0.167	0.183
b	0.69	1.02	0.027	0.040
b(1)	1.14	1.78	0.045	0.070
c	0.36	0.61	0.014	0.024
D	14.33	15.85	0.564	0.624
E	9.96	10.52	0.392	0.414
e	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.10	6.71	0.240	0.264
J(1)	2.41	2.92	0.095	0.115
L	13.36	14.40	0.526	0.567
L(1)	3.33	4.04	0.131	0.159
Ø P	3.53	3.94	0.139	0.155
Q	2.54	3.00	0.100	0.118

ECN: X15-0364-Rev. C, 14-Dec-15
DWG: 6031

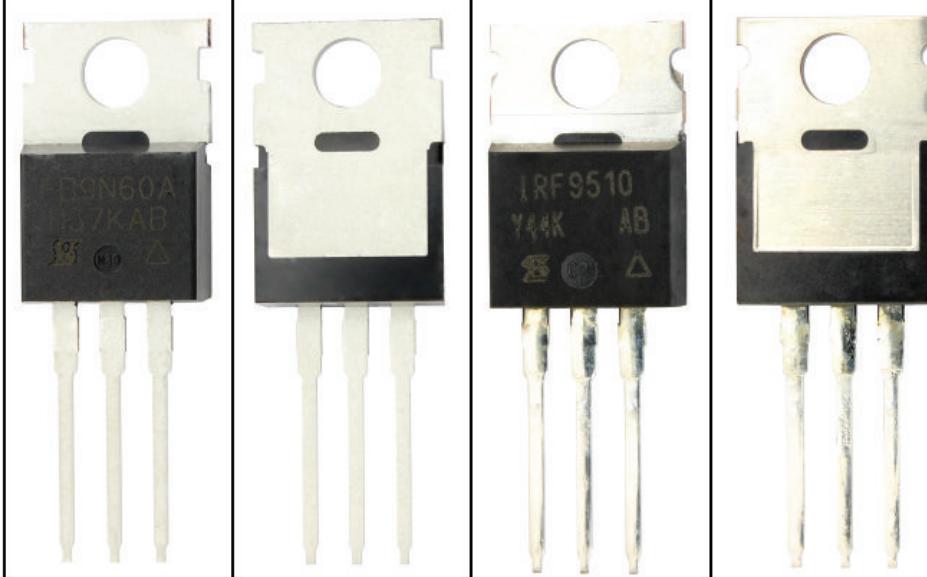
Note

- M^* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM

Package Picture

ASE

Xi'an





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